

Search Notes

Application/Control No.

10/665,259

Examiner

Patrick J. Lee

Applicant(s)/Patent under
Reexamination

WANG ET AL.

Art Unit

2878

SEARCHED

Class	Subclass	Date	Examiner
250	214.1	11/21/05 11/22/05	PL
257	222, 225		PL
257	233, 257		PL
257	288, 290		PL
257	431		PL
Updated	search	4/3/2006	PL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference search attached		4/24/2006	PL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted w/ S. Allen AU 2878 CL 250	11/21/2005	PL
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	11/21/2005	PL
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	11/22/2005	PL
East (see attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	4/3/2006	PL